UNISONIC TECHNOLOGIES CO., LTD

22NM50 **Preliminary Power MOSFET**

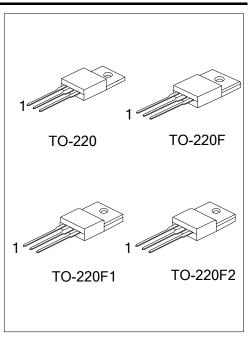
22A, 500V N-CHANNEL SUPER-JUNCTION MOSFET

DESCRIPTION

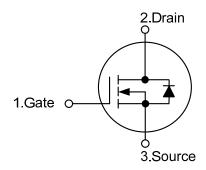
The UTC 22NM50 is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

FEATURES

- * $R_{DS(ON)}$ < 0.15 Ω @ V_{GS} =10V, I_D =11A
- * Fast Switching Capability
- * Avalanche Energy Specified
- * Improved dv/dt Capability, High Ruggedness



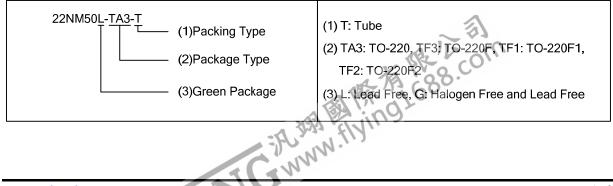
SYMBOL



ORDERING INFORMATION

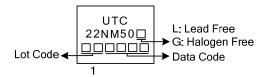
Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
22NM50L-TA3-T	22NM50G-TA3-T	TO-220	G	D	S	Tube	
22NM50L-TF3-T	22NM50G-TF3-T	TO-220F	G	D	S	Tube	
22NM50L-TF1-T	22NM50G-TF1-T	TO-220F1	G	D	S	Tube	
22NM50L-TF2-T	22NM50G-TF2-T	TO-220F2	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



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MARKING





■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	500	V	
Gate-Source Voltage		V_{GSS}	±30	V	
Drain Current	Continuous	I_D	22	Α	
	Pulsed (Note 2)	I_{DM}	88	Α	
Avalanche Current (Note 2)		I _{AR}	9.9	Α	
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	833	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	8.6	V/ns	
	TO-220		235	W	
Power Dissipation	TO-220F/TO-220F1 TO-220F2	P_{D}	390	W	
Junction Temperature		TJ	+150	°C	
Storage Temperature		T _{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L = 17mH, I_{AS} = 9.9A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 4. $I_{SD} \le 22A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient		θ_{JA}	62.5	°C/W
Junction to Case	TO-220		0.53	°C/W
	TO-220F/TO-220F1 TO-220F2	θ_{JC}	5.0	°C/W



ELECTRICAL CHARACTERISTICS (T_J =25°C, unless otherwise specified)

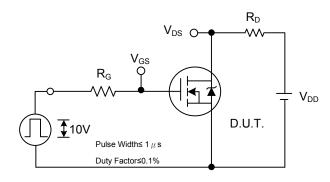
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	V_{GS} =0V, I_D =250 μ A	500			V
Drain-Source Leakage Current		I_{DSS}	V _{DS} =500V, V _{GS} =0V			50	μΑ
Gate- Source Leakage Current	Forward		V_{DS} =0V, V_{GS} =+30V			+100	nA
	Reverse	I_{GSS}	V_{DS} =0V, V_{GS} =-30V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.5		4.5	V
Static Drain-Source On-Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =11A			0.15	Ω
DYNAMIC PARAMETERS							
Input Capacitance		C _{ISS}			1440		рF
Output Capacitance		Coss	V _{DS} =25V, V _{GS} =0V, f=1.0MHz		1385		pF
Reverse Transfer Capacitance		C _{RSS}			119		рF
SWITCHING PARAMETERS							
Total Gate Charge (Note 1)		Q_G	V _{DS} =50V, V _{GS} =10V, I _D =1.3A		159		nC
Gate to Source Charge		Q_{GS}	I_{G} = 100µA (Note1, 2)		12		nC
Gate to Drain Charge		Q_GD	IG- 100μΑ (Note 1, 2)		48		nC
Turn-ON Delay Time (Note 1)		$t_{D(ON)}$			70		ns
Rise Time		t_R	V_{DS} =30V, V_{GS} =10V, I_{D} =0.5A,		232		ns
Turn-OFF Delay Time		$t_{D(OFF)}$	R _G =25Ω (Note1, 2)		360		ns
Fall-Time		t_{F}			327		ns
SOURCE- DRAIN DIODE RATING	S AND CHA	RACTERIST	TICS		ā.		
Maximum Body-Diode Continuous Current		I_S				22	Α
Maximum Body-Diode Pulsed Current		I _{SM}				88	Α
Drain-Source Diode Forward Voltage (Note 1)		V_{SD}	I _S =22A, V _{GS} =0V			1.4	V
Body Diode Reverse Recovery Time (Note 1)		t _{rr}	I _S =22A, V _{GS} =0V,		450		ns
Body Diode Reverse Recovery Charge		Qrr	dI _F /dt=100A/μs		8.1		μC

Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%.



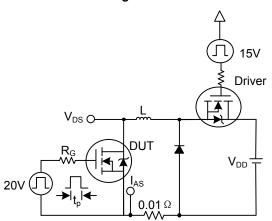
^{2.} Essentially independent of operating ambient temperature.

TEST CIRCUITS AND WAVEFORMS

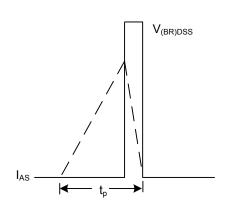


 V_{DS} 90% 10% V_{GS}

Switching Test Circuit

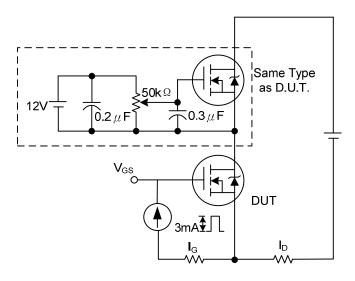


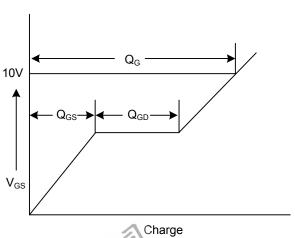
Switching Waveforms



Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

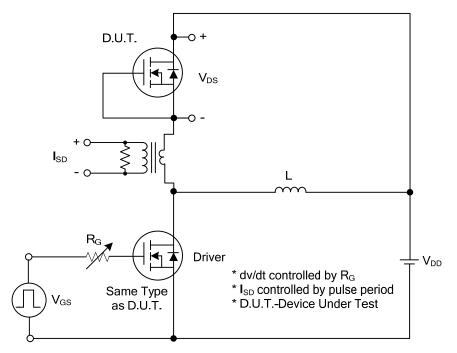




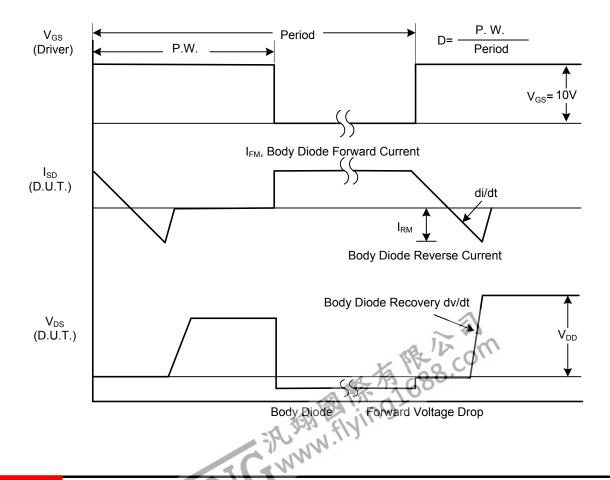
Gate Charge Test Circuit

Gate Charge Waveform

■ TEST CIRCUITS AND WAVEFORMS



Peak Diode Recovery dv/dt Test Circuit



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